# 74LV4052

# **Dual 4-channel analog multiplexer/demultiplexer**

Rev. 7 — 29 March 2024

Product data sheet

## 1. General description

The 74LV4052 is a dual single-pole quad-throw analog switch suitable for use in 4:1 multiplexer/demultiplexer applications. Each switch features four independent inputs/outputs (nY0, nY1, nY2 and nY3) and a common input/output (nZ). A digital enable input ( $\bar{E}$ ) and two digital select inputs (S0, S1) are common to both switches. When  $\bar{E}$  is HIGH, the switches are turned off. Digital inputs include clamp diodes. This enables the use of current limiting resistors to interface inputs to voltages in excess  $V_{CC}$ .

#### 2. Features and benefits

- Wide supply voltage range from 1.0 to 6.0 V
- CMOS low power dissipation
- Latch-up performance exceeds 100 mA per JESD 78 Class II Level B
- · Optimized for low-voltage applications: 1.0 V to 6.0 V
- Accepts TTL input levels between V<sub>CC</sub> = 2.7 V and V<sub>CC</sub> = 3.6 V
- · Low ON resistance:
  - 145  $\Omega$  (typical) at  $V_{CC}$   $V_{EE}$  = 2.0 V
  - 90  $\Omega$  (typical) at V<sub>CC</sub> V<sub>EE</sub> = 3.0 V
  - 60 Ω (typical) at V<sub>CC</sub> V<sub>EE</sub> = 4.5 V
- · Logic level translation:
  - To enable 3 V logic to communicate with ± 3 V analog signals
- Typical 'break before make' built in
- Complies with JEDEC standards:
  - JESD8-7 (1.65 V to 1.95 V)
  - JESD8-5 (2.3 V to 2.7 V)
  - JESD8C (2.7 V to 3.6 V)
  - JESD36 (4.5 V to 5.5 V)
- ESD protection:
  - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
  - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- Specified from -40 °C to +85 °C and from -40 °C to +125 °C

# 3. Ordering information

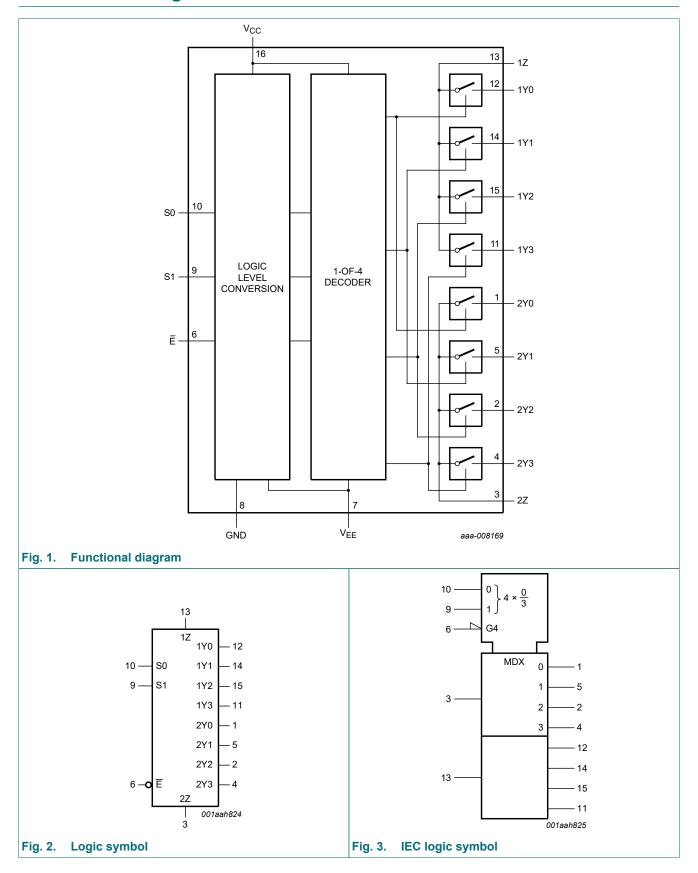
**Table 1. Ordering information** 

Type number	Package							
Type mamme.	Temperature range	Name	Description	Version				
74LV4052D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1				
74LV4052PW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1				

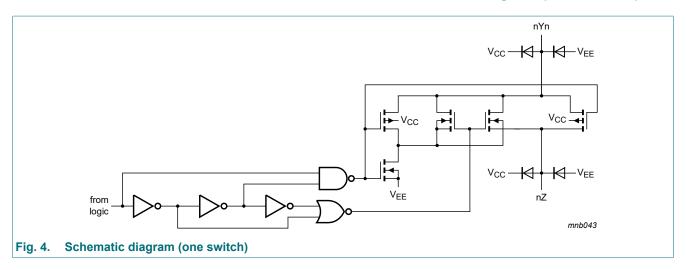


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# 4. Functional diagram

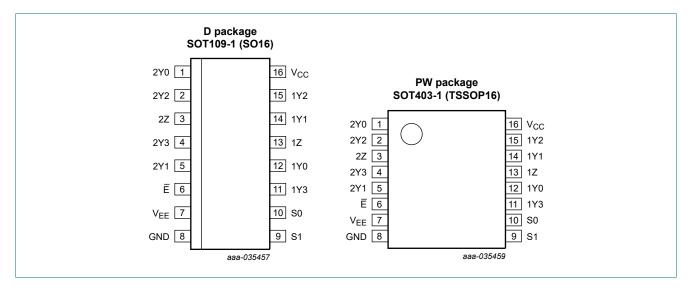


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# 5. Pinning information

## 5.1. Pinning



## 5.2. Pin description

**Table 2. Pin description** 

Symbol	Pin	Description
2Y0, 2Y1, 2Y2, 2Y3	1, 5, 2, 4	independent input or output
E	6	enable input (active LOW)
V <sub>EE</sub>	7	negative supply voltage
GND	8	ground (0 V)
S0, S1	10, 9	select logic input
1Y0, 1Y1, 1Y2, 1Y3	12, 14, 15, 11	independent input or output
1Z, 2Z	13, 3	common input or output
V <sub>CC</sub>	16	positive supply voltage

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# 6. Functional description

#### **Table 3. Function table**

 $H = HIGH \ voltage \ level; \ L = LOW \ voltage \ level; \ X = don't \ care.$ 

Input	nput					
Ē	S1	S0				
L	L	L	nY0 and nZ			
L	L	Н	nY1 and nZ			
L	Н	L	nY2 and nZ			
L	Н	Н	nY3 and nZ			
Н	X	X	none			

# 7. Limiting values

#### **Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to  $V_{SS} = 0 \text{ V}$  (ground).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>CC</sub>	supply voltage		[1]	-0.5	+7.0	V
I <sub>IK</sub>	input clamping current	$V_{I} < -0.5 \text{ V or } V_{I} > V_{CC} + 0.5 \text{ V}$	[2]	-	±20	mA
I <sub>SK</sub>	switch clamping current	$V_{SW}$ < -0.5 V or $V_{SW}$ > $V_{CC}$ + 0.5 V	[2]	-	±20	mA
I <sub>SW</sub>	switch current	$V_{SW}$ > -0.5 V or $V_{SW}$ < $V_{CC}$ + 0.5 V; source or sink current	[2]	-	±25	mA
T <sub>stg</sub>	storage temperature			-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +125 °C	[3]	-	500	mW

<sup>[1]</sup> To avoid drawing V<sub>CC</sub> current out of terminal nZ, when switch current flows into terminals nYn, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal nZ, no V<sub>CC</sub> current flows out of terminals nYn. In this case, there is no limit for the voltage drop across the switch, but the voltages at nYn and nZ may not exceed V<sub>CC</sub> or V<sub>EE</sub>.

# 8. Recommended operating conditions

Table 5. Recommended operating conditions

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>CC</sub>	supply voltage	see <u>Fig. 5</u> [1	] 1	3.3	6	V
VI	input voltage		0	-	V <sub>CC</sub>	V
V <sub>SW</sub>	switch voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature	in free air	-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 1.0 V to 2.0 V	-	-	500	ns/V
		V <sub>CC</sub> = 2.0 V to 2.7 V	-	-	200	ns/V
		V <sub>CC</sub> = 2.7 V to 6.0 V	-	-	100	ns/V

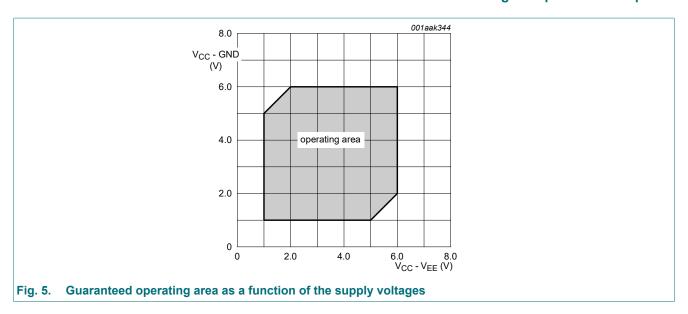
<sup>[1]</sup> The static characteristics are guaranteed from  $V_{CC}$  = 1.2 V to 6.0 V. However, LV devices are guaranteed to function down to  $V_{CC}$  = 1.0 V (with input levels GND or  $V_{CC}$ ).

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<sup>[2]</sup> The minimum input voltage rating may be exceeded if the input current rating is observed.

<sup>[3]</sup> For SOT109-1 (SO16) package:  $P_{tot}$  derates linearly with 12.4 mW/K above 110 °C. For SOT403-1 (TSSOP16) package:  $P_{tot}$  derates linearly with 8.5 mW/K above 91 °C.

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## 9. Static characteristics

**Table 6. Static characteristics** 

At recommended operating conditions. Voltages are referenced to GND (ground = 0 V).

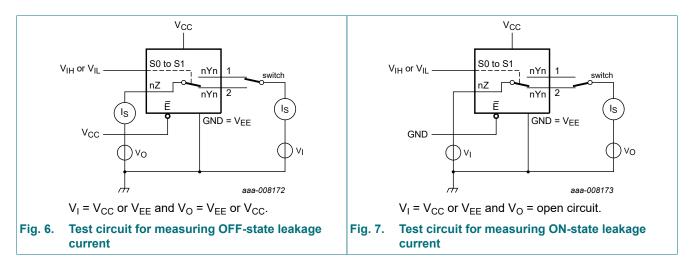
Symbol	Parameter	Conditions	-40	°C to +85	5 °C	-40 °C to	Unit	
			Min	Typ[1]	Max	Min	Max	
V <sub>IH</sub>	HIGH-level	V <sub>CC</sub> = 1.2 V	0.9	-	-	0.9	-	V
	input voltage	V <sub>CC</sub> = 2.0 V	1.4	-	-	1.4	-	V
		V <sub>CC</sub> = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
		V <sub>CC</sub> = 4.5 V	3.15	-	-	3.15	-	V
		V <sub>CC</sub> = 6.0 V	4.20	-	-	4.20	-	V
V <sub>IL</sub>		V <sub>CC</sub> = 1.2 V	-	-	0.3	-	0.3	V
	voltage	V <sub>CC</sub> = 2.0 V	-	-	0.6	-	0.6	V
		V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
		V <sub>CC</sub> = 4.5 V	-	-	1.35	-	1.35	V
		$V_{CC} = 6.0 \text{ V}$ - 1.80 -	-	1.80	V			
I <sub>I</sub>	input leakage	V <sub>I</sub> = V <sub>CC</sub> or GND						
	current	V <sub>CC</sub> = 3.6 V	-	-	1.0	-	1.0	μΑ
		V <sub>CC</sub> = 6.0 V	-	-	2.0	-	2.0	μΑ
I <sub>S(OFF)</sub>	OFF-state	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; see <u>Fig. 6</u>						
	leakage current	V <sub>CC</sub> = 3.6 V	-	-	1.0	-	1.0	μΑ
		V <sub>CC</sub> = 6.0 V	-	-	2.0	-	2.0	μΑ
I <sub>S(ON)</sub>	ON-state	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; see <u>Fig. 7</u>						
	leakage current	V <sub>CC</sub> = 3.6 V	-	-	1.0	-	1.0	μΑ
		V <sub>CC</sub> = 6.0 V	-	-	2.0	-	2.0	μΑ
I <sub>CC</sub>	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A						
		V <sub>CC</sub> = 3.6 V	-	-	20	-	40	μΑ
		V <sub>CC</sub> = 6.0 V	-	-	40	-	80	μΑ
Δl <sub>CC</sub>	additional supply current	per input; $V_1 = V_{CC} - 0.6 \text{ V}$ ; $V_{CC} = 2.7 \text{ V to } 3.6 \text{ V}$	-	-	500	-	850	μΑ

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Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to	Unit	
			Min	Typ[1]	Max	Min	Max	
Cı	input capacitance		-	3.5	-	-	-	pF
C <sub>sw</sub>	switch	independent pins nYn	-	5	-	-	-	pF
	capacitance	common pins nZ	-	12	-	-	-	pF

[1] Typical values are measured at  $T_{amb}$  = 25 °C.

### 9.1. Test circuits



#### 9.2. ON resistance

#### **Table 7. ON resistance**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit and graph see Fig. 8 and Fig. 9.

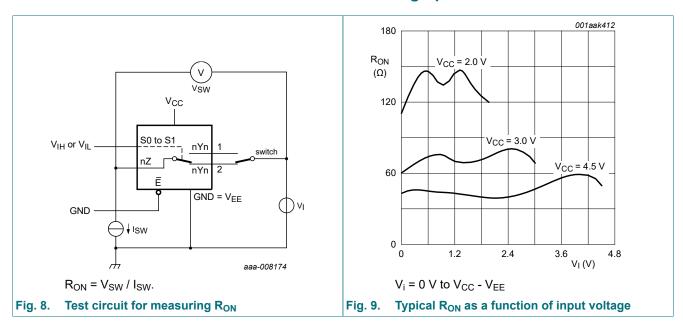
Symbol	Parameter	Conditions		-40	°C to +8	5 °C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
R <sub>ON(peak)</sub>		V <sub>I</sub> = 0 V to V <sub>CC</sub> - V <sub>EE</sub>							
	(peak)	V <sub>CC</sub> = 1.2 V; I <sub>SW</sub> = 100 μA	[2]	-	-	-	-	-	Ω
		V <sub>CC</sub> = 2.0 V; I <sub>SW</sub> = 1000 μA		-	145	325	-	375	Ω
	V <sub>CC</sub> = 2.7 V; I <sub>SW</sub> = 1000 μA		-	90	200	-	235	Ω	
	V <sub>CC</sub> = 3.0 V to 3.6 V; I <sub>SW</sub> = 1000 μA		-	80	180	-	210	Ω	
		V <sub>CC</sub> = 4.5 V; I <sub>SW</sub> = 1000 μA		-	60	135	-	160	Ω
		V <sub>CC</sub> = 6.0 V; I <sub>SW</sub> = 1000 μA		-	55	125	-	145	Ω
$\Delta R_{ON}$	ON resistance	$V_I = 0 V \text{ to } V_{CC} - V_{EE}$							
	mismatch between channels	V <sub>CC</sub> = 1.2 V; I <sub>SW</sub> = 100 μA	[2]	-	-	-	-	-	Ω
	Chamicis	V <sub>CC</sub> = 2.0 V; I <sub>SW</sub> = 1000 μA		-	5	-	-	-	Ω
		V <sub>CC</sub> = 2.7 V; I <sub>SW</sub> = 1000 μA		-	4	-	-	-	Ω
		V <sub>CC</sub> = 3.0 V to 3.6 V; I <sub>SW</sub> = 1000 μA		-	4	-	-	-	Ω
		V <sub>CC</sub> = 4.5 V; I <sub>SW</sub> = 1000 μA		-	3	-	-	-	Ω
		V <sub>CC</sub> = 6.0 V; I <sub>SW</sub> = 1000 μA		-	2	-	-	-	Ω

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Symbol	Parameter	Conditions		-40	°C to +8	5°C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	
R <sub>ON(rail)</sub>	ON resistance (rail)	V <sub>I</sub> = GND							
		V <sub>CC</sub> = 1.2 V; I <sub>SW</sub> = 100 μA	[2]	-	225	-	-	-	Ω
		V <sub>CC</sub> = 2.0 V; I <sub>SW</sub> = 1000 μA		-	110	235	-	270	Ω
		V <sub>CC</sub> = 2.7 V; I <sub>SW</sub> = 1000 μA		-	70	145	-	165	Ω
		V <sub>CC</sub> = 3.0 V to 3.6 V; I <sub>SW</sub> = 1000 μA		-	60	130	-	150	Ω
		V <sub>CC</sub> = 4.5 V; I <sub>SW</sub> = 1000 μA		-	45	100	-	115	Ω
		V <sub>CC</sub> = 6.0 V; I <sub>SW</sub> = 1000 μA		-	40	85	-	100	Ω
R <sub>ON(rail)</sub>	ON resistance (rail)	V <sub>I</sub> = V <sub>CC</sub> - V <sub>EE</sub>							
		V <sub>CC</sub> = 1.2 V; I <sub>SW</sub> = 100 μA	[2]	-	250	-	-	-	Ω
		V <sub>CC</sub> = 2.0 V; I <sub>SW</sub> = 1000 μA		-	120	320	-	370	Ω
		V <sub>CC</sub> = 2.7 V; I <sub>SW</sub> = 1000 μA		-	75	195	-	225	Ω
		V <sub>CC</sub> = 3.0 V to 3.6 V; I <sub>SW</sub> = 1000 μA		-	70	175	-	205	Ω
		V <sub>CC</sub> = 4.5 V; I <sub>SW</sub> = 1000 μA		-	50	130	-	150	Ω
		V <sub>CC</sub> = 6.0 V; I <sub>SW</sub> = 1000 μA		-	45	120	-	135	Ω

# 9.3. On resistance test circuit and graph



Typical values are measured at  $T_{amb}$  = 25 °C. When supply voltages ( $V_{CC}$  -  $V_{EE}$ ) near 1.2 V the analog switch ON resistance becomes extremely non-linear. When using a supply of 1.2 V, only use these devices for transmitting digital signals.

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# 10. Dynamic characteristics

#### **Table 8. Dynamic characteristics**

Voltages are referenced to GND (ground = 0 V). For test circuit, see Fig. 12.

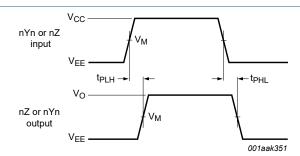
Symbol	Parameter	Conditions		-40	°C to +8	5°C	-40 °C to	+125 °C	Unit
				Min	Typ[1]	Max	Min	Max	-
t <sub>pd</sub>	propagation delay	nYn to nZ, nZ to nYn; see Fig. 10	[2]						
		V <sub>CC</sub> = 1.2 V		-	25	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	9	17	-	20	ns
		V <sub>CC</sub> = 2.7 V		-	6	13	-	15	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	[3]	-	5	10	-	12	ns
		V <sub>CC</sub> = 4.5 V		-	4	9	-	10	ns
		V <sub>CC</sub> = 6.0 V		-	3	7	-	8	ns
t <sub>en</sub>	enable time	E, Sn to nYn, nZ; see Fig. 11	[2]						
		V <sub>CC</sub> = 1.2 V		-	190	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	65	121	-	146	ns
		V <sub>CC</sub> = 2.7 V		-	48	89	-	108	ns
		$V_{CC}$ = 3.0 V to 3.6 V; $C_L$ = 15 pF	[3]	-	30	-	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	[3]	-	36	71	-	86	ns
		V <sub>CC</sub> = 4.5 V		-	32	60	-	73	ns
		V <sub>CC</sub> = 6.0 V		-	25	46	-	56	ns
t <sub>dis</sub>	disable time	E, Sn to nYn, nZ; see Fig. 11	[2]						
		V <sub>CC</sub> = 1.2 V		-	125	-	-	-	ns
		V <sub>CC</sub> = 2.0 V		-	43	80	-	95	ns
		V <sub>CC</sub> = 2.7 V		-	33	59	-	71	ns
		$V_{CC}$ = 3.0 V to 3.6 V; $C_L$ = 15 pF	[3]	-	22	-	-	-	ns
		V <sub>CC</sub> = 3.0 V to 3.6 V	[3]	-	26	48	-	57	ns
		V <sub>CC</sub> = 4.5 V		-	23	41	-	49	ns
		V <sub>CC</sub> = 6.0 V		-	18	32	-	38	ns
C <sub>PD</sub>	power dissipation capacitance	$C_L$ = 50 pF; $f_i$ = 1 MHz; $V_i$ = GND to $V_{CC}$	[4]	-	57	-	-	-	pF

- [1] All typical values are measured at  $T_{amb}$  = 25 °C.
- [2]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .
  - ten is the same as tPZL and tPZH.
- $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ . Typical values are measured at nominal supply voltage (V<sub>CC</sub> = 3.3 V).
- $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ).
  - $P_D = C_{PD} x V_{CC}^2 x f_i x N + \Sigma((C_L + C_{sw}) x V_{CC}^2 x f_o)$  where:
  - $f_i$  = input frequency in MHz,  $f_o$  = output frequency in MHz
  - $C_L$  = output load capacitance in pF
  - $C_{sw}$  = maximum switch capacitance in pF;
  - V<sub>CC</sub> = supply voltage in Volts
  - N = number of inputs switching
  - $\Sigma(C_L \times V_{CC}^2 \times f_0)$  = sum of the outputs.

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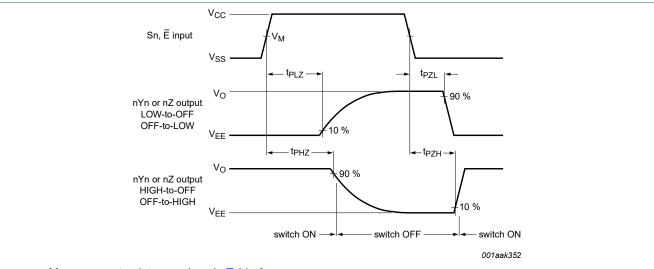
#### 10.1. Waveforms and test circuit



Measurement points are given in Table 9.

 $V_{\text{OL}}$  and  $V_{\text{OH}}$  are typical voltage output levels that occur with the output load.

Fig. 10. nYn, nZ to nZ, nYn propagation delays



Measurement points are given in Table 9.

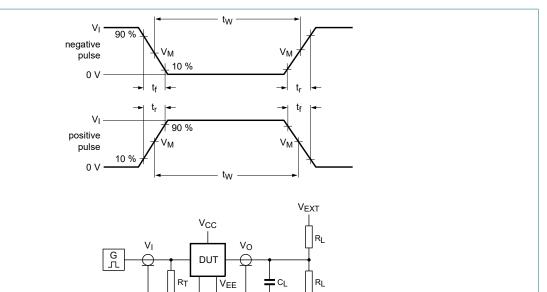
 $\ensuremath{V_{OL}}$  and  $\ensuremath{V_{OH}}$  are typical voltage output levels that occur with the output load.

Fig. 11. Enable and disable times

**Table 9. Measurement points** 

rabio or modearoment points	water of medical points							
Supply voltage	Input	Output						
V <sub>CC</sub>	V <sub>M</sub>	V <sub>M</sub>						
< 2.7 V	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>						
2.7 V to 3.6 V	1.5 V	1.5 V						
> 3.6 V	0.5V <sub>CC</sub>	0.5V <sub>CC</sub>						

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Test data is given in Table 10.

Definitions for test circuit:

R<sub>L</sub> = Load resistance.

 $C_L$  = Load capacitance including jig and probe capacitance.

 $R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

V<sub>EXT</sub> = External voltage for measuring switching times.

Fig. 12. Test circuit for measuring switching times

Table 10. Test data

Supply voltage	Input		Load		V <sub>EXT</sub>		
V <sub>CC</sub>	V <sub>I</sub>	t <sub>r</sub> , t <sub>f</sub>	CL	R <sub>L</sub>	t <sub>PHL</sub> , t <sub>PLH</sub>	t <sub>PZH</sub> , t <sub>PHZ</sub>	t <sub>PZL</sub> , t <sub>PLZ</sub>
< 2.7 V	V <sub>CC</sub>	≤ 6 ns	50 pF	1 kΩ	open	V <sub>EE</sub>	2V <sub>CC</sub>
2.7 V to 3.6 V	2.7 V	≤ 6 ns	15 pF, 50 pF	1 kΩ	open	V <sub>EE</sub>	2V <sub>CC</sub>
> 3.6 V	V <sub>CC</sub>	≤ 6 ns	50 pF	1 kΩ	open	V <sub>EE</sub>	2V <sub>CC</sub>

## 10.2. Additional dynamic parameters

#### **Table 11. Additional dynamic characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $V_I$  = GND or  $V_{CC}$  (unless otherwise specified);  $t_r$  =  $t_f$  ≤ 6.0 ns;  $T_{amb}$  = 25 °C.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
THD	total harmonic distortion	$f_i$ = 1 kHz; $C_L$ = 50 pF; $R_L$ = 10 kΩ; see <u>Fig. 13</u>				
		V <sub>CC</sub> = 3.0 V; V <sub>I</sub> = 2.75 V (p-p)	-	0.8	-	%
		V <sub>CC</sub> = 6.0 V; V <sub>I</sub> = 5.5 V (p-p)	-	0.4	-	%
		$f_i$ = 10 kHz; $C_L$ = 50 pF; $R_L$ = 10 kΩ; see <u>Fig. 13</u>				
		V <sub>CC</sub> = 3.0 V; V <sub>I</sub> = 2.75 V (p-p)	-	2.4	-	%
		$V_{CC} = 6.0 \text{ V}; V_I = 5.5 \text{ V (p-p)}$	-	1.2	-	%
f <sub>(-3dB)</sub>	-3 dB frequency response	$C_L = 50 \text{ pF}; R_L = 50 \Omega; \text{ see } Fig. 14 \text{ and } Fig. 15$ [1]				
		V <sub>CC</sub> = 3.0 V	-	180	-	MHz
		V <sub>CC</sub> = 6.0 V	-	200	-	MHz

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Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$\alpha_{iso}$	isolation (OFF-state)	$f_i$ = 1 MHz; $C_L$ = 50 pF; $R_L$ = 600 $\Omega$ ; see <u>Fig. 16</u> and [2] <u>Fig. 17</u>				
		V <sub>CC</sub> = 3.0 V	-	-50	-	dB
		V <sub>CC</sub> = 6.0 V	_	-50	-	dB
V <sub>ct</sub>	crosstalk voltage	between digital inputs and switch; $f_i$ = 1 MHz; $C_L$ = 50 pF; $R_L$ = 600 $\Omega$ ; see Fig. 18				
		V <sub>CC</sub> = 3.0 V	-	0.11	-	V
		V <sub>CC</sub> = 6.0 V	-	0.12	-	V
Xtalk	crosstalk	between switches; $f_i$ = 1 MHz; $C_L$ = 50 pF; $R_L$ = 600 $\Omega$ ; [2] see Fig. 19				
		V <sub>CC</sub> = 3.0 V	-	-60	-	dB
		V <sub>CC</sub> = 6.0 V	_	-60	-	dB

- [1] To obtain 0 dBm level at output for 1 MHz (0 dBm = 1 mW into 50  $\Omega$ ), adjust  $f_i$  voltage.
- [2] To obtain 0 dBm level at output for 1 MHz (0 dBm = 1 mW into 600  $\Omega$ ), adjust f<sub>i</sub> voltage.

#### 10.2.1. Test circuits

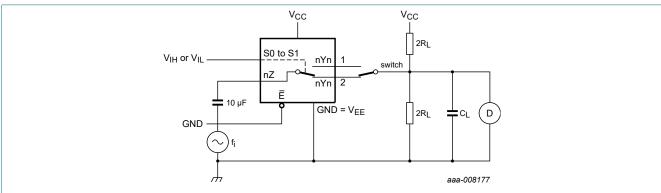
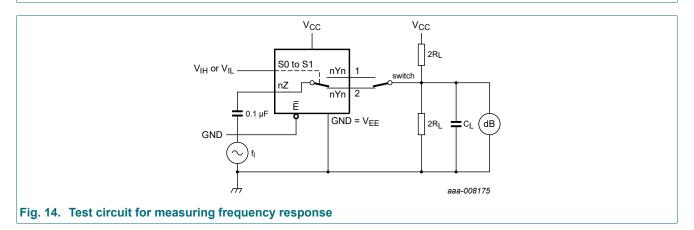
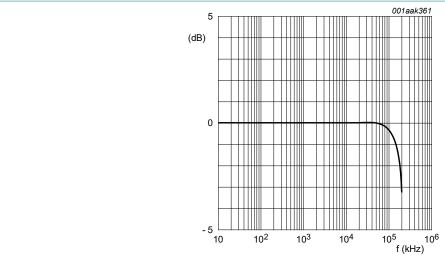


Fig. 13. Test circuit for measuring total harmonic distortion



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 $V_{CC}$  = 3.0 V; GND = 0 V;  $V_{EE}$  = - 3.0 V;  $R_L$  = 50  $\Omega$ ;  $R_{SOURCE}$  = 1 k $\Omega$ .

Fig. 15. Typical frequency response

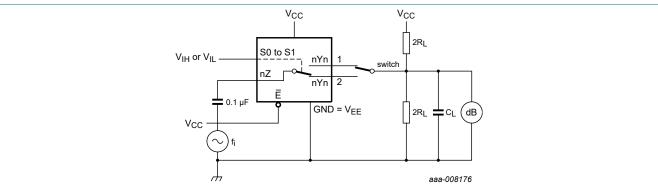


Fig. 16. Test circuit for measuring isolation (OFF-state)

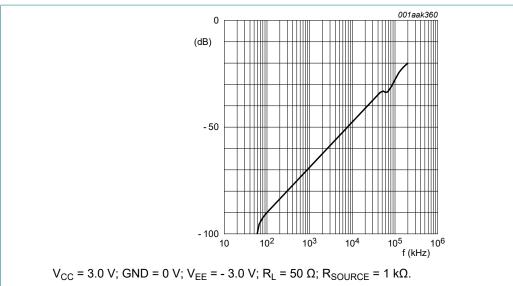


Fig. 17. Typical isolation (OFF-state) as function of frequency

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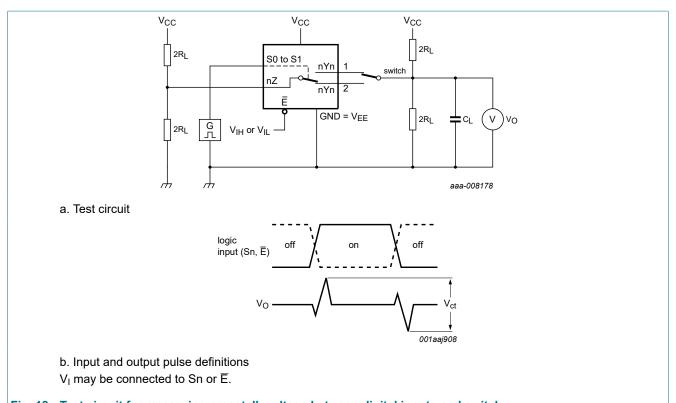
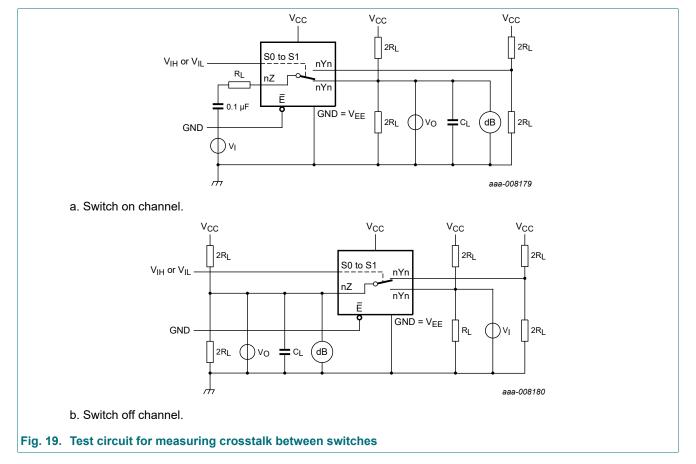


Fig. 18. Test circuit for measuring crosstalk voltage between digital inputs and switch



#### Dual 4-channel analog multiplexer/demultiplexer

# 11. Package outline

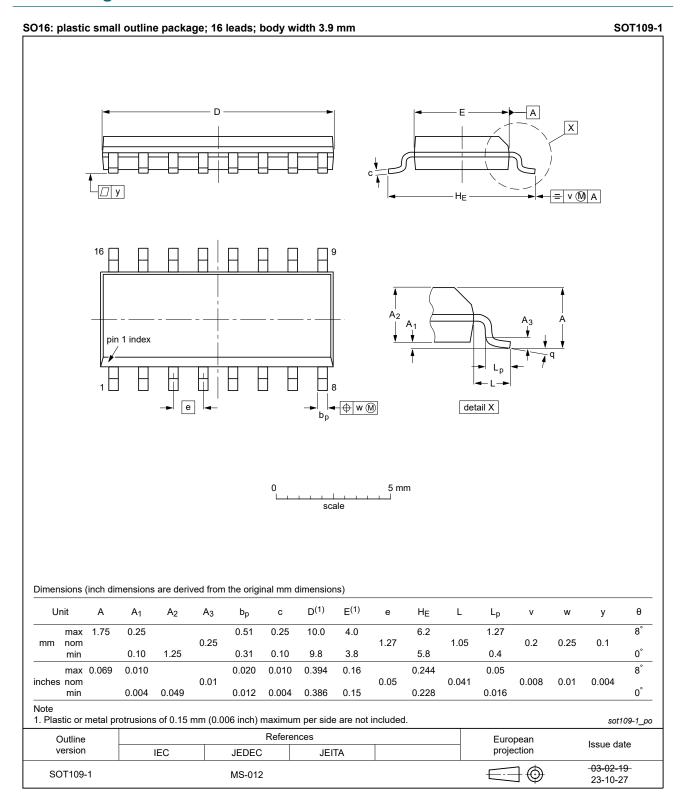


Fig. 20. Package outline SOT109-1 (SO16)

#### Dual 4-channel analog multiplexer/demultiplexer

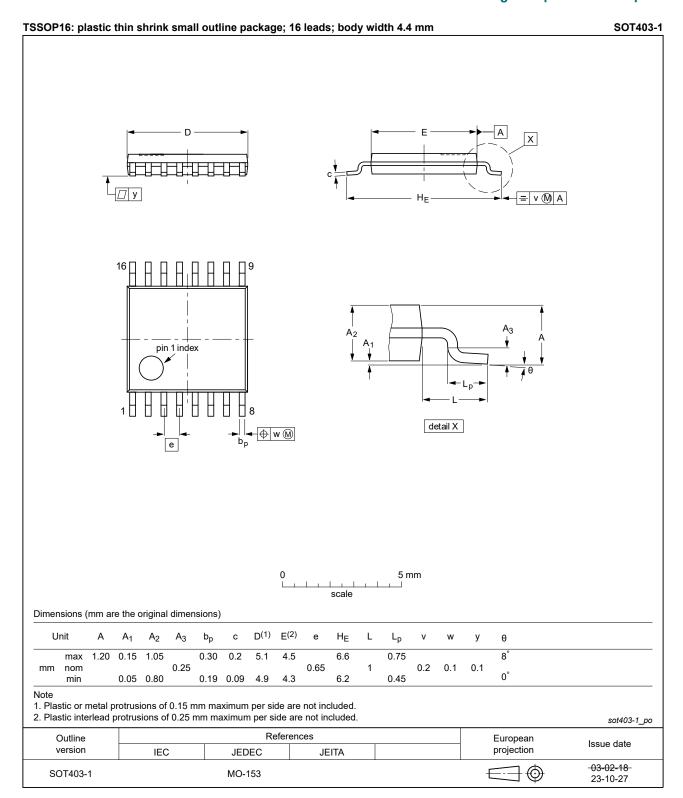


Fig. 21. Package outline SOT403-1 (TSSOP16)

## **Dual 4-channel analog multiplexer/demultiplexer**

# 12. Abbreviations

#### **Table 12. Abbreviations**

Acronym	Description
CDM	Charged Device Model
CMOS	Complementary Metal-Oxide Semiconductor
ESD	ElectroStatic Discharge
НВМ	Human Body Model
TTL	Transistor-Transistor Logic

# 13. Revision history

#### **Table 13. Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes	
74LV4052 v.7	20240329	Product data sheet	-	74LV4052 v.6	
Modifications:		D specification updated accord g. 21: Aligned SO and TSSOP	-		
74LV4052 v.6	20210924	Product data sheet	-	74LV4052 v.5	
Modifications:	Nexperia.  • Legal texts ha • <u>Section 1</u> and • <u>Section 7</u> : Del	this data sheet has been redestive been adapted to the new consection 2 updated.  rating values for P <sub>tot</sub> total power 74LV4052DB (SOT338-1/SSO	ompany name where	e appropriate.	
74LV4052 v.5	20160317	Product data sheet	-	74LV4052 v.4	
Modifications:	Type number	74LV4052N (SOT38-4) remove	ed.		
74LV4052 v.4	20130701	Product data sheet	-	74LV4052 v.3	
Modifications:	guidelines of N	<ul> <li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>Legal texts have been adapted to the new company name where appropriate.</li> </ul>			
74LV4052 v.3	19980623	Product specification	-	74LV4052 v.2	
74LV4052 v.2	19970715	Product specification	-	-	

## 14. Legal information

#### **Data sheet status**

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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